



Nessrine Elloumi <ellouminessrine@gmail.com>

Thank you for the review of PAAA-D-22-00784R1 - [EMID:0bf16b8df6272bf5]

M. Hassaballah <em@editorialmanager.com>
Répondre à : "M. Hassaballah" <m.hassaballah@svu.edu.eg>
À : Nessrine Elloumi <ellouminessrine@gmail.com>

14 mars 2023 à 11:04

Dear
Dr. Elloumi,

Many thanks for reviewing the following manuscript for Pattern Analysis and Applications Journal
(<https://www.editorialmanager.com/paaa/>)

NSIWD: New Statistical Image Watermark Detector
Theoretical advances
PAAA-D-22-00784R1

Your review is extremely valuable for us to make decisions on the manuscript. Once all of the reviews have been received, I will be making a decision on the paper and forwarding this recommendation to the Editor-in-Chief who will directly inform the authors. In case of any decision that requires the authors to make changes for a second round of reviewing, I am assuming that you will be happy to read a revised version for a subsequent review.

Thanks you very much for your continued help and assistance to the journal.

Sincerely,

Dr. M. Hassaballah
Associate Editor
Pattern Analysis and Applications

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Nessrine Elloumi <ellouminessrine@gmail.com>

Thank you for the review of PAAA-D-22-00835 - [EMID:534ca2f59090616f]

1 message

José Salvador Sánchez Garreta <em@editorialmanager.com>

8 février 2023 à 11:11

Répondre à : José Salvador Sánchez Garreta <sanchez@uji.es>

À : Nessrine Elloumi <ellouminessrine@gmail.com>

Dear
Dr. Elloumi,

Many thanks for reviewing the following manuscript for Pattern Analysis and Applications Journal
(<https://www.editorialmanager.com/paaa/>)

Graph-based Fine-grained Model Selection for Multi-source Domain
Theoretical advances
PAAA-D-22-00835

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Prof. José Salvador Sánchez Garreta
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Nessrine Elloumi <ellouminessrine@gmail.com>

Thank you for the review of PAAA-D-22-00784 - [EMID:78245c94cc2ba3ca]

M. Hassaballah <em@editorialmanager.com>
Répondre à : "M. Hassaballah" <m.hassaballah@svu.edu.eg>
À : Nessrine Elloumi <ellouminessrine@gmail.com>

13 janvier 2023 à 14:46

Dear
Dr. Elloumi,

Many thanks for reviewing the following manuscript for Pattern Analysis and Applications Journal
(<https://www.editorialmanager.com/paaa/>)

NSIWD: New Statistical Image Watermark Detector
Theoretical advances
PAAA-D-22-00784

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Nessrine Elloumi <ellouminessrine@gmail.com>

Thank you for the review of PAAA-D-22-00524 - [EMID:1c2373c990c440a8]

Vincenzo Carletti <em@editorialmanager.com>
Répondre à : Vincenzo Carletti <vcarletti@unisa.it>
À : Nessrine Elloumi <ellouminessrine@gmail.com>

18 octobre 2022 à 10:28

Dear
Dr. Elloumi,

Many thanks for reviewing the following manuscript for Pattern Analysis and Applications Journal
(<https://www.editorialmanager.com/paaa/>)

Improved Exploiting Modification Direction Steganography for Hexagonal Image Processing
Theoretical advances
PAAA-D-22-00524

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Nessrine Elloumi <ellouminessrine@gmail.com>

Thank you for the review of PAAA-D-22-00490 - [EMID:9fd0690b8c7eb8b7]

Felix Albu <em@editorialmanager.com>

1 septembre 2022 à 15:14

Répondre à : Felix Albu <felix.albu@valahia.ro>

À : Nessrine Elloumi <ellouminessrine@gmail.com>

Dear
Dr. Elloumi,

Many thanks for reviewing the following manuscript for Pattern Analysis and Applications Journal
(<https://www.editorialmanager.com/paaa/>)

DTMF: Decision based Trimmed Multimode approach Filter for denoising MRI images
Industrial and commercial application
PAAA-D-22-00490

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Sincerely,

Prof. Felix Albu
Associate Editor
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